

# M29F040

# SINGLE SUPPLY 4 Megabit (512K x 8, Sector Erase) FLASH MEMORY

#### **PRELIMINARY DATA**

- VERY FAST ACCESS TIME: 70ns
- 5V ± 10% SUPPLY VOLTAGE for PROGRAM and ERASE OPERATIONS
- 5V ± 10% SUPPLY VOLTAGE in READ OPERATIONS
- 10µs TYPICAL PROGRAMMING TIME
- PROGRAM/ERASE CONTROLLER (P/E.C.)
  - Program Byte-by-Byte
  - Data Polling and Toggle Protocol for P/E.C. Status
- MEMORY ERASE in SECTORS
  - 8 Sectors of 64K Bytes each
  - Sector Protection
  - Multisector Erase
- ERASE SUSPEND and RESUME MODES
- 100,000 PROGRAM/ERASE CYCLES per SECTOR
- **LOW POWER CONSUMPTION** 
  - 25µA Typical in Standby
- STANDARD EPROM/OTP MEMORY PACKAGES: TSOP32, PLCC32 and PDIP32
- EXTENDED TEMPERATURE RANGES

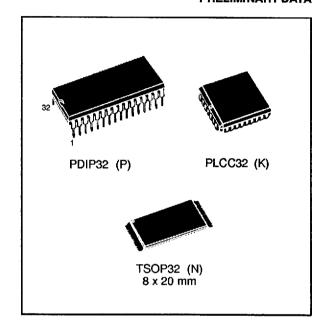


Figure 1. Logic Diagram

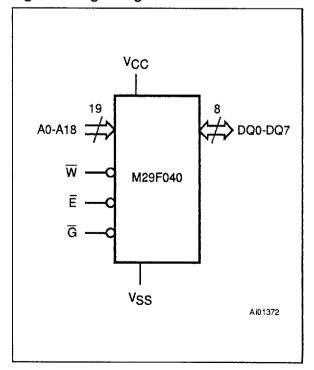


Table 1. Signal Names

| A0-A18          | Address Inputs       |
|-----------------|----------------------|
| DQ0-DQ7         | Data Input / Outputs |
| Ē               | Chip Enable          |
| G               | Output Enable        |
| w               | Write Enable         |
| Vcc             | Supply Voltage       |
| V <sub>SS</sub> | Ground               |

Figure 2A. DIP Pin Connections

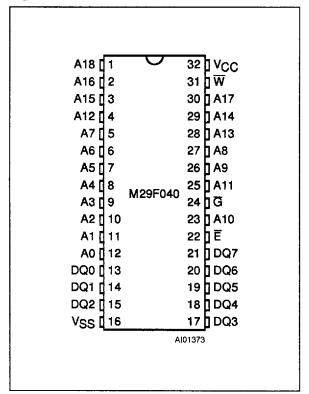


Figure 2B. LCC Pin Connections

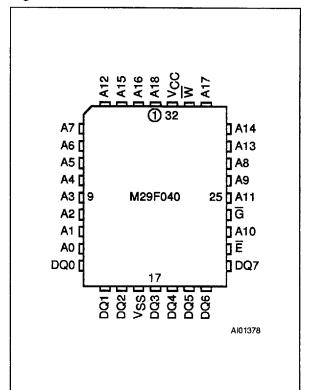


Figure 2C. TSOP Pin Connections

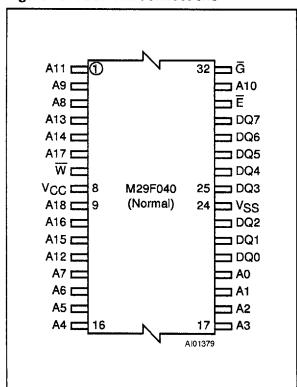


Figure 2D. TSOP Reverse Pin Connections

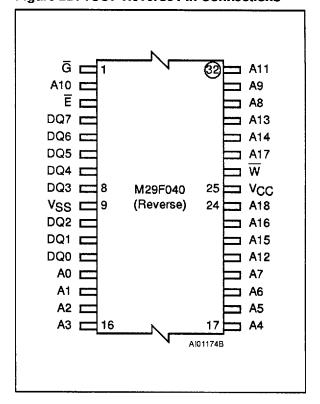


Table 2. Absolute Maximum Ratings (1)

| Symbol                         | Parameter                     |  | Value   | Unit |
|--------------------------------|-------------------------------|--|---|------|
| TA                             | Ambient Operating Temperature | grade 1<br>grade 3<br>grade 5<br>grade 6 | 0 to 70<br>-40 to 125<br>-20 to 85<br>-40 to 85 | •c   |
| T <sub>BIAS</sub>              | Temperature Under Bias        |  | -50 to 125                                      | •C   |
| T <sub>STG</sub>               | Storage Temperature           |  | -65 to 150                                      | °C   |
| V <sub>10</sub> <sup>(2)</sup> | Input or Output Voltages      |  | -0.6 to 7                                       | V    |
| Vcc                            | Supply Voltage                |  | -0.6 to 7                                       | V    |
| V <sub>A9</sub> (2)            | A9 Voltage                    |  | -0.6 to 13.5                                    | V    |

Notes: 1. Except for the rating "Operating Temperature Range", stresses above those listed in the Table "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the SGS-THOMSON SURE Program and other relevant quality documents.

2. Minimum Voltage may undershoot to -2V during transition and for less than 20ns.

#### DESCRIPTION

The M29F040 is a non-volatile memory that may be erased electrically at the sector level, and programmed Byte-by-Byte.

The interface is directly compatible with most microprocessors. PDIP32, PLCC32 and TSOP32 (8 x 20mm) packages are available. Both normal and reverse pin outs are available for the TSOP32 package.

#### Organisation

The FLASH Memory organisation is 512K x 8 bits with Addresslines A0-A18 and Data Inputs/Outputs DQ0-DQ7. Memory control is provided by Chip Enable, Output Enable and Write Enable Inputs.

Erase and Program are performed through the internal Program/Erase Controller (P/E.C.).

Data Outputs bits DQ7 and DQ6 provide polling or toggle signals during Automatic Program or Erase to indicate the Ready/Busy state of the internal Program/Erase Controller.

#### **Sectors**

Erasure of the memory is in sectors. There are 8 sectors of 64K bytes each in the memory address space. Erasure of each sector takes typically 1.5 seconds and each sector can be programmed and erased over 100,000 cycles. Each sector may separately be protected and unprotected against program and erase. Sector erasure may be suspended, while data is read from other blocks of the memory, and then resumed.

## **Bus Operations**

Seven operations can be performed by the appropriate bus cycles, Read Array, Read Electronic Signature, Output Disable, Standby, Protect Sector, Unprotect Sector, and Write the Command of an Instruction.

#### **Command Interface**

Command Bytes can be written to a Command Interface (C.I.) latch to perform Reading (from the Array or Electronic Signature), Erasure or Programming. For added data protection, command execution starts after 4 or 6 command cycles. The first, second, fourth and fifth cycles are used to input a code sequence to the Command Interface (C.I.). This sequence is equal for all P/E.C. instructions. Command itself and its confirmation - if it applies - are given on the third and fourth or sixth cycles.

#### Instructions

Seven instructions are defined to perform Read Memory Array, Read Electronic Signature, Auto Program, Sector Auto Erase, Auto Bulk Erase, Sector Erase Suspend and Sector Erase Resume. The internal Program/Erase Controller (P/E.C.) handles all timing and verification of the Program and Erase instructions and provides Data Polling, Toggle, and Status data to indicate completion of Program and Erase Operations.

Instructions are composed of up to six cycles. The first two cycles input a code sequence to the Command Interface which is common to all P/E.C.



**Table 3. Operations** 

| Operation      | Ē               | G               | w               | DQ0 - DQ7   |
|----------------|-----------------|-----------------|-----------------|-------------|
| Read           | V <sub>IL</sub> | V <sub>IL</sub> | V <sub>IH</sub> | Data Output |
| Write          | V <sub>iL</sub> | V <sub>IH</sub> | V <sub>IL</sub> | Data Input  |
| Output Disable | VIL             | V <sub>IH</sub> | ViH             | Hi-Z        |
| Standby        | V <sub>IH</sub> | Х               | ×               | Hi-Z        |

Note:  $X = V_{IL}$  or  $V_{IH}$ 

**Table 4. Electronic Signature** 

| Code           | Ē               | Ğ   | w               | A0              | <b>A</b> 1 | <b>A</b> 6      | A9              | Other<br>Addresses | DQ0 - DQ7 |
|----------------|-----------------|-----|-----------------|-----------------|------------|-----------------|-----------------|--------------------|-----------|
| Manufact. Code | V <sub>IL</sub> | ViL | V <sub>IH</sub> | V <sub>IL</sub> | VIL        | V <sub>IL</sub> | V <sub>ID</sub> | Don't Care         | 20h       |
| Device Code    | V <sub>IL</sub> | VIL | ViH             | VIH             | VIL        | V <sub>IL</sub> | V <sub>ID</sub> | Don't Care         | 0E2h      |

**Table 5. Sector Protection Status** 

| Code               | Ë               | G               | w               | A0  | <b>A</b> 1      | <b>A6</b>       | A16 | A17 | A18 | Other<br>Addresses | DQ0 - DQ7 |
|--------------------|-----------------|-----------------|-----------------|-----|-----------------|-----------------|-----|-----|-----|--------------------|-----------|
| Protected Sector   | VIL             | V <sub>IL</sub> | V <sub>IH</sub> | VIL | V <sub>IH</sub> | V <sub>IL</sub> | SA  | SA  | SA  | Don't Care         | 01h       |
| Unprotected Sector | V <sub>IL</sub> | VIL             | V <sub>IH</sub> | VIL | V <sub>IH</sub> | V <sub>IL</sub> | SA  | SA  | SA  | Don't Care         | 00h       |

Note: SA = Address of sector being checked

# **DESCRIPTION** (cont'd)

instructions (see Table 7 for Command Descriptions). The third cycle inputs the instruction set up command instruction to the Command Interface. Subsequent cycles output Signature, Sector protection or the addressed data for Read operations. For added data protection, the instructions for program and sector or bulk erase require further command inputs. For a Program instruction, the fourth command cycle inputs the address and data to be programmed. For an Erase instruction (sector or bulk), the fourth and fifth cycles input a further code sequence before the Erase confirm command on the sixth cycle. Byte programming takes typically 10µs while erase is performed in typically 1.5 seconds.

Erasure of a memory sector may be suspended, in order to read data from another sector, and then resumed. Data Polling, Toggle and Error data may be read at any time, including during the programming or erase cycles, to monitor the progress of

the operation. When power is first applied or if  $V_{CC}$  falls below  $V_{LKO}$ , the command interface is reset to Read Array.

#### **DEVICE OPERATION**

#### Signal Descriptions

A0-A18 Address Inputs. The address inputs for the memory array are latched during a write operation. The A9 address input is used also for the Electronic Signature read and Sector Protect verification. When A9 is raised to V<sub>ID</sub>, either a Read Manufacturer Code, Read Device Code or Verify Sector Protection is enabled depending on the combination of levels on A0, A1 and A6. When A0, A1 and A6 are Low, the Electronic Signature Manufacturer code is read, when A0 is High and A1 and A6 are Low, the Device code is read, and when A1 is High and A0 and A6 are low, the Sector Protection Status is read for the sector addressed by A16, A17, A18.

# **Table 6. Instructions**

| Mne.              | Instr.             | Cyc. |                    | 1st Cyc.                              | 2nd Cyc.                  | 3rd Cyc.   | 4th Cyc.                              | 5th Cyc.   | 6th Cyc.          | 7th Cyc.                 |  |
|-------------------|--------------------|------|--------------------|---------------------------------------|---------------------------|--|---------------------------------------|--|-------------------|--------------------------|--|
| RD <sup>(2)</sup> | Read/Reset         | 1+   | Addr. (1,5)        | Х                                     | Read Men                  | Memory Array until a new write cycle is initiated. |                                       |  |                   |                          |  |
|                   | Memory Array       | 17   | Data               | 0F0h                                  | Ticad Men                 | nory Array   | and a non mile by old to initiation.  |  |                   |                          |  |
| RD <sup>(2)</sup> | Read/Reset         | 3+   | Addr. (1,5)        | x5555h                                | x2AAAh                    | x5555h   | Read Mer                              | nory Array   | until a new       | write                    |  |
|                   | Memory Array       | 0,   | Data               | 0AAh                                  | 55h                       | 0F0h   | cycle is initiated.                   |  |                   |                          |  |
| RSIG (2)          | Read<br>Electronic | 3+   | Addr. (1,5)        | x5555h                                | x2AAAh                    | x5555h   | Read Electronic Signature until a new |  |                   |                          |  |
| noid              | Signature          | 3+   | Data               | 0AAh                                  | 55h                       | 90h  |                                       |  | I. See Note       |                          |  |
| RSP (2)           | Read Sector        | 3+   | Addr. (1,5)        | x5555h                                | x2AAAh                    | x5555h   | Read Sec                              | Sector Protection until a new write s initiated. See Note 4. |                   |                          |  |
| 1101              | Protection         | 01   | Data               | 0AAh                                  | 55h                       | 90h  | cycle is in                           |  |                   |                          |  |
| PG                | Program            | 4    | Addr. (1,5)        | x5555h                                | x2AAAh                    | x5555h   | Program<br>Address                    | Read Data Polling or Toggle                                  |                   |                          |  |
|                   | i rogium           | •    | Data               | 0AAh                                  | 55h                       | 0A0h   | Program<br>Data                       | Bit until Pi   | rogram con        | npletes.                 |  |
| SE                | Sector Erase       | 6    | Addr. (1,5)        | x5555h                                | x2AAAh                    | x5555h   | x5555h                                | x2AAAh   | Sector<br>Address | Additional<br>Sector (6) |  |
|                   |                    |      | Data               | 0AAh                                  | 55h                       | 80h  | 0AAh                                  | 55h  | 30h               | 30h                      |  |
| BE                | Bulk Erase         | 6    | <b>Addr.</b> (1,5) | x5555h                                | x2AAAh                    | x5555h   | x5555h                                | x2AAAh   | x5555h            | Note 7                   |  |
|                   |                    | •    | Data               | 0AAh                                  | 55h                       | 80h  | 0AAh                                  | 55h  | 10h               | Note /                   |  |
| ES                | Erase              | 1    | Addr. (1,5)        | Х                                     | Read until                | Toggle sto   | ps, then re                           | ad all the d   | lata needed       | from any                 |  |
|                   | Suspend            |      | Data               | 0B0h                                  | sector(s) r               | s) not being erased then Resume Erase.             |                                       |  |                   |                          |  |
| ER                | Erase              | 1    | Addr. (1,5)        | 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 |                           |  |                                       |  | or Erase          |                          |  |
|                   | Resume             | -    | Data               | 30h                                   | is suspended another time |  |                                       |  |                   |                          |  |

Notes: 1. X = Don't Care.

2. The first cycle of the RD, RSP or RSIG instruction is followed by read operations to read memory array, Status Register or Electronic Signature codes. Any number of read cycles can occur after one command cycle.

3. Signature Address bits A0, A1, A6 at V<sub>IL</sub> will output Manufacturer code (20h). Address bits A0 at V<sub>IH</sub> and A1, A6 at V<sub>IL</sub> will output Device code (0E2h).

4. Protection Address: A0, A6 at Vil., A1 at Vill and A16, A17, A18 within the sector to be checked, will output the Sector Protection status.

5. Address bits A16, A17, A18 are don't care for coded address inputs.

6. Optional, additional sectors addresses must be entered within a 80µs delay after last write entry, timeout status can be verified through DQ3 value. When full command is entered, read Data Polling or Toggle bit until Erase is completed or suspended.

7. Read Data Polling or Toggle bit until Erase completes.

**DQ0-DQ7 Data Input/Outputs.** The data input is a byte to be programmed or a command written to the C.I. Both are latched when Chip Enable  $\overline{E}$  and Write Enable  $\overline{W}$  are active. The data output is from the memory Array, the Electronic Signature, the Data Polling bit (DQ7), the Toggle Bit (DQ6), the Error bit (DQ5) or the Erase Timer bit (DQ3). Ouputs are valid when Chip Enable  $\overline{E}$  and Output Enable  $\overline{G}$  are active. The output is high impedance when the chip is deselected or the outputs are disabled.

**E** Chip Enable. The Chip Enable activates the memory control logic, input buffers, decoders and sense amplifiers. E High deselects the memory and reduces the power consumption to the standby level. E can also be used to control writing to the command register and to the memory array, while

Table 7. Commands

| Hex Code | Command  |
|----------|--|
| 00h      | Invalid/Reserved                                       |
| 10h      | Bulk Erase Confirm                                     |
| 30h      | Sector Erase Resume/Confirm                            |
| 80h      | Set-up Erase   |
| 90h      | Read Electronic Signature/<br>Sector protection Status |
| 0A0h     | Program  |
| 0B0h     | Erase Suspend  |
| 0F0h     | Read Array/Reset                                       |

Table 8. Status Register

| DQ | Name              | Logic Level       | Definition                                | Note   |
|----|-------------------|-------------------|---|--|
|    |                   | '1'               | Erase Complete                            | Indicates the P/E.C. status, check during  |
| 7  | Data<br>Polling   | '0'               | Erase on Going                            | Program or Erase, and on completion before checking bits DQ5 for Program or  |
|    |                   | DQ                | Program Complete                          | Erase Success.   |
|    |                   | DQ                | Program on Going                          |  |
|    |                   | '-1-0-1-0-1-0-1-' | Erase or Program on Going                 | Successive read output complementary   |
| 6  | Toggle Bit        | '-0-0-0-0-0-0-'   | Program ('0' on DQ6)<br>Complete          | data on DQ6 while Programming or Erase operations are going on. DQ6 remain at constant level when P/E.C. operations are  |
|    |                   | '-1-1-1-1-1-1-'   | Erase or Program<br>('1' on DQ6) Complete | completed or Erase Suspend is acknowledged.  |
| 5  | Error Bit         | '1'               | Program or Erase Error                    | This bit is set to '1' if P/E.C. has exceded   |
|    | LIIO. DIL         | ,0,               | Program or Erase on Going                 | the specified time limits.   |
| 4  |                   | '1'               |   |  |
|    |                   | 'O'               |   |  |
|    |                   | '1'               | Erase Timeout Period Expired              | P/E.C. Erase operation has started. Only   |
| 3  | Erase<br>Time Bit | '0'               | Erase Timeout Period on Going             | possible command entry is Erase Suspend (ES). An additional sector to be erased in parallel can be entered to the P/E.C. |
| 2  | Reserved          |                   |   |  |
| 1  | Reserved          |                   |   |  |
| 0  | Reserved          |                   |   |  |

Notes: Logic level '1' is High, '0' is Low. -0-1-0-0-0-1-1-1-0- represent bit value in successive Read operations.

W remains at a low level. Addresses are then latched on the falling edge of E while data is latched on the rising edge of E. The Chip Enable must be forced to V<sub>ID</sub> during Sector Unprotect operations.

 $\overline{\mathbf{G}}$  Output Enable. The Output Enable gates the outputs through the data buffers during a read operation.  $\overline{\mathbf{G}}$  must be forced to  $V_{ID}$  level during Sector Protect and Sector Unprotect operations.

W Write Enable. This input controls writing to the Command Register and Address and Data latches. Addresses are latched on the falling edge of W, and Data Inputs are latched on the rising edge of W.

Vcc **Supply Voltage.** The power supply for all operations (Read, Program and Erase).

 $V_{SS}$  Ground.  $V_{SS}$  is the reference for all voltage measurements.

## **Memory Sectors**

The memory sectors of the M29F040 are shown in Figure 5. The memory array is divided in 8 sectors of 64K bytes. Each sector can be erased separately or any combination of sectors can be erased simultaneously. The Sector Erase operation is managed automatically by the P/E.C. The operation can be suspended in order to read from any another sector, and then resumed.

Sector Protection provides additional data security. Each sector can be separately protected or unprotected against Program or Erase. Bringing A9 and  $\overline{G}$  to  $V_{ID}$  initiates protection, while bringing A9,  $\overline{G}$  and  $\overline{E}$  to  $V_{ID}$  cancels the protection. The sector affected during protection is addressed by the inputs on A16, A17, and A18. Unprotect operation affects all sectors.

## **Operations**

Operations are defined as specific bus cycles and signals which allow Memory Read, Command Write, Output Disable, Standby, Read Status Bits, Sector Protect/Unprotect, Sector Protection Check and Electronic Signature Read. They are shown in Tables 3, 4, 5.

Read. Read operations are used to output the contents of the Memory Array, the Status Register or the Electronic Signature. Both Chip Enable E and Output Enable G must be low in order to read the output of the memory. The Chip Enable input also provides power control and should be used for device selection. Output Enable should be used to gate data onto the output independent of the device selection. The data read depends on the previous command written to the memory (see instructions RD and RSIG, and Status Bits).

Write. Write operations are used to give Instruction Commands to the memory or to latch input data to be programmed. A write operation is initiated when Chip Enable  $\overline{E}$  is Low and Write Enable  $\overline{W}$  is Low with Output Enable  $\overline{G}$  High. Addresses are latched on the falling edge of  $\overline{W}$  or  $\overline{E}$  whichever occurs last. Commands and Input Data are latched on the rising edge of  $\overline{W}$  or  $\overline{E}$  whichever occurs first.

Output Disable. The data outputs are high impedance when the Output Enable G is High with Write Enable W High.

**Standby.** The memory is in standby when Chip Enable E is High and Program/Erase Controller P./E.C. is Idle. The power consumption is reduced to the standby level and the outputs are high impedance, independent of the Output Enable G or Write Enable W inputs.

Electronic Signature. Two codes identifying the manufacturer and the device can be read from the memory, the manufacturer's code for SGS-THOM-SON is 20h, and the device codes is E2h for the M29F040. These codes allow programming equipment or applications to automatically match their interface to the characteristics of the particular manufacturer's product. The Electronic Signature is output by a Read operation when the voltage applied to A9 is at  $V_{\rm ID}$  and address inputs A1 and A6 are at Low. The manufacturer code is output when the Address input A0 is Low and the device code when this input is High. Other Address inputs are ignored. The codes are output on DQ0-DQ7. This is shown in Table 4.

The Electronic Signature can also be read, without raising A9 to  $V_{\rm ID}$  by giving the memory the instruction RSIG (see below).

Sector Protection. Each sector can be separately protected against Program or Erase. Sector Protection provides additional data security, as it disables all program or erase operations. This mode is activated when both A9 and G are set to V<sub>ID</sub> and the sector address is applied on A16, A17 and A18. Sector protection is programmed using a Presto F program like algorithm. Protection is initiated on the edge of  $\overline{W}$  falling to  $V_{IL}$ . Then after a delay of 100µs, the edge of W rising to VIH ends the protection operation. Protection verify is achieved by bringing  $\overline{G}$ ,  $\overline{E}$  and A6 to  $V_{IL}$  while  $\overline{W}$  is at VIH and A9 at VID. Under these conditions, reading the data output will yield 01h if the sector defined by the inputs on A16, A17 and A18 is protected. Any attempt to program or erase a protected sector will be ignored by the device.

Any protected sector can be unprotected to allow updating of bit contents. All sectors must be pro-

**Table 9. AC Measurement Conditions** 

|                                       | SRAM Interface Levels | EPROM Interface Levels |
|---------------------------------------|-----------------------|------------------------|
| Input Rise and Fall Times             | ≤ 10ns                | ≤ 10ns                 |
| Input Pulse Voltages                  | 0 to 3V               | 0.45V to 2.4V          |
| Input and Output Timing Ref. Voltages | 1.5V                  | 0.8V and 2V            |

Figure 3. AC Testing Input Output Waveform

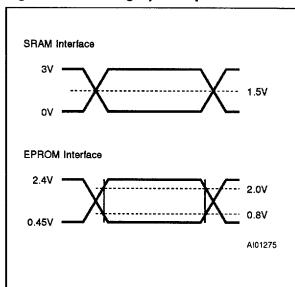


Figure 4. AC Testing Load Circuit

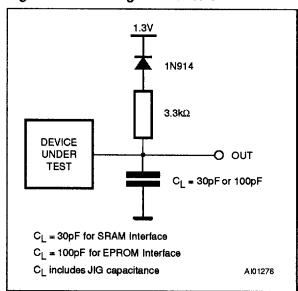


Table 10. Capacitance (1)  $(T_A = 25 \, ^{\circ}\text{C}, f = 1 \, \text{MHz})$ 

| Symbol           | Parameter          | Test Condition       | Min | Max | Unit |
|------------------|--------------------|----------------------|-----|-----|------|
| Cin              | Input Capacitance  | V <sub>IN</sub> = 0V |     | 6   | pF   |
| C <sub>OUT</sub> | Output Capacitance | Vout = <b>0</b> V    |     | 12  | pF   |

Note: 1. Sampled only, not 100% tested.

# **DEVICE OPERATION (cont'd)**

tected before an unprotect operation. Sector unprotect is activated when A9,  $\overline{G}$  and  $\overline{E}$  are at V<sub>ID</sub>. The addresses inputs A6, A16, A12 must be maintained at V<sub>IH</sub>. Sector unprotect is performed through a Presto F Erase like algorithm. Unprotect is initiated by the edge of  $\overline{W}$  falling to V<sub>IL</sub>. After a delay of 10ms, the edge of  $\overline{W}$  rising to V<sub>IH</sub> will end the unprotection operation. Unprotect verify is achieved by bringing  $\overline{G}$  and  $\overline{E}$  to V<sub>IL</sub> while A6 and  $\overline{W}$  are at V<sub>IH</sub> and A9 at V<sub>ID</sub>. In these conditions, reading the output data will yield 00h if the sector defined by the inputs on A16, A17 and A18 has been successfully unprotected. All combinations of A16, A17 and A18 must be addressed in order to

ensure that all of the 8 sectors have been unprotected. Sector Protection Status is shown in Table 5.

#### Instructions and Commands

The Command Interface (C.I.) latches commands written to the memory. Instructions are made up from one or more commands to perform memory Read, Read Electronic Signature, Sector Erase, Bulk Erase, Program, Sector Erase Suspend and Erase Resume. Commands are made of address and data sequences. Addresses are latched on the falling edge of  $\overline{W}$  or  $\overline{E}$  and data is latched on the rising of  $\overline{W}$  or  $\overline{E}$ . The instructions require from 1 to 6 cycles, the first or first three of which are always write operations used to initiate the command.

Figure 5. Memory Map and Sector Address Table

| A18    | A17 | A16 |                  | TOP<br>ADDRESS | BOTTOM<br>ADDRESS |
|--------|-----|-----|------------------|----------------|-------------------|
| 1      | 1   | 1   | 64K Bytes Sector | 7FFFFh         | 70000h            |
| 1      | 1   | 0   | 64K Bytes Sector | 6FFFFh         | 60000h            |
| 1      | 0   | 1   | 64K Bytes Sector | 5FFFFh         | 50000h            |
| 1      | 0   | 0   |                  | 4FFFFh         | 40000h            |
| 0      | 1   | 1   |                  | 3FFFFh         | 30000h            |
| 0      | 1   | 0   | _                | 2FFFFh         | 20000h            |
| 0      | 0   | 1   | 64K Bytes Sector | 1FFFFh         | 10000h            |
| 0      | 0   | 0   | 64K Bytes Sector | OFFFFh         | 00000h            |
| d01362 |     |     |                  | •              |                   |

Table 11. DC Characteristics (T<sub>A</sub> = 0 to 70°C, -20 to 85°C, -40 to 85°C or -40 to 125°C;  $V_{CC}$  = 5V  $\pm$  10%)

| Symbol           | Parameter                                   | Test Condition   | Min                    | Max       | Unit |
|------------------|---|--|------------------------|-----------|------|
| lu               | Input Leakage Current                       | 0V ≤ V <sub>IN</sub> ≤ V <sub>CC</sub>                   |                        | ±1        | μΑ   |
| llo              | Output Leakage Current                      | 0V ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub>                  |                        | ±1        | μΑ   |
| lcc1             | Supply Current (Read) TTL                   | $\overline{E} = V_{IL}, \overline{G} = V_{IH}, f = 6MHz$ |                        | 40        | mA   |
| I <sub>CC2</sub> | Supply Current (Standby) TTL                | E = V <sub>IH</sub>                                      |                        | 1         | mA   |
| Іссз             | Supply Current (Standby) CMOS               | $\overline{E} = V_{CC} \pm 0.2V$                         |                        | 100       | μА   |
| Icc4             | Supply Current (Program or Erase)           | Byte program, Sector or<br>Bulk Erase in progress        |                        | 60        | mA   |
| ViL              | Input Low Voltage                           |  | -0.5                   | 0.8       | ٧    |
| V <sub>IH</sub>  | Input High Voltage                          |  | 2                      | Vcc + 0.5 | ٧    |
| Vol              | Output Low Voltage                          | loL = 12mA   |                        | 0.45      | ٧    |
|                  | Output High Voltage TTL                     | I <sub>OH</sub> = -2.5mA                                 | 2.4                    |           | ٧    |
| VoH              | Output High Voltage CMOS                    | l <sub>OH</sub> = -100μA                                 | V <sub>CC</sub> -0.4V  |           | ٧    |
|                  | Output Flight Voltage OlviOS                | I <sub>OH</sub> = -2.5mA                                 | 0.85 x V <sub>CC</sub> |           | ٧    |
| $V_{ID}$         | A9 Voltage (Electronic Signature)           |  | 11.5                   | 12.5      | ٧    |
| l <sub>ID</sub>  | A9 Current (Electronic Signature)           | A9 = V <sub>ID</sub>                                     |                        | 50        | μΑ   |
| V <sub>LKO</sub> | Supply Voltage (Erase and Program lock-out) |  | 3.2                    | 4.2       | ٧    |

Table 12A. Read AC Characteristics

|                              |              |  |  |                     | M29     | F040                |         |      |
|------------------------------|--------------|--|--|---------------------|---------|---------------------|---------|------|
|                              |              |  |  | -70 <sup>(3)</sup>  |         | -90                 |         | ĺ    |
| Symbol                       | Alt          | Parameter                                  | Test Condition                                 | V <sub>CC</sub> = ! | 5V ± 5% | V <sub>CC</sub> = 5 | V ± 10% | Unit |
|                              |              |  |  | SRAM<br>Interface   |         | EPROM<br>Interface  |         |      |
|                              |              |  |  | Min                 | Max     | Min                 | Max     |      |
| tavav                        | trac         | Address Valid to Next Address Valid        | $\overline{E} = V_{IL}, \overline{G} = V_{IL}$ | 70                  |         | 90                  |         | ns   |
| t <sub>AVQV</sub>            | <b>t</b> ACC | Address Valid to Output Valid              | $\overline{E} = V_{IL}, \overline{G} = V_{IL}$ |                     | 70      |                     | 90      | ns   |
| t <sub>ELQX</sub> (1)        | tLZ          | Chip Enable Low to Output Transition       | G = V <sub>IL</sub>                            | 0                   |         | 0                   |         | ns   |
| t <sub>ELQV</sub> (2)        | <b>t</b> ce  | Chip Enable Low to Output Valid            | G = V <sub>IL</sub>                            |                     | 70      |                     | 90      | ns   |
| tGLQX (1)                    | tolz         | Output Enable Low to Output<br>Transition  | Ë = V <sub>IL</sub>                            | 0                   |         | 0                   |         | ns   |
| <b>t</b> gLav <sup>(2)</sup> | toe          | Output Enable Low to Output Valid          | E = ViL  |                     | 30      |                     | 35      | ns   |
| <b>t</b> енох                | tон          | Output Enable High to Output<br>Transition | G = V <sub>IL</sub>                            | 0                   |         | 0                   |         | ns   |
| t <sub>EHQZ</sub> (1)        | <b>t</b> HZ  | Chip Enable High to Output Hi-Z            | $\overline{G} = V_{iL}$                        |                     | 20      |                     | 20      | ns   |
| t <sub>GHQX</sub>            | tон          | Output Enable High to Output<br>Transition | E = V <sub>IL</sub>                            | 0                   |         | 0                   |         | ns   |
| t <sub>GHQZ</sub> (1)        | <b>t</b> or  | Output Enable High to Output Hi-Z          | E = V <sub>IL</sub>                            |                     | 20      |                     | 20      | ns   |
| <b>t</b> axax                | tон          | Address Transition to Output Transition    | E = V <sub>IL</sub> , G = V <sub>IL</sub>      | 0                   |         | 0                   |         | ns   |

Notes: 1. Sampled only, not 100% tested.
2. G may be delayed by up to telov - tolov after the falling edge of E without increasing telov.
3. At grade 1 (0 to 70°C) temperature range.

# **DEVICE OPERATION** (cont'd)

They are followed by either further write cycles to confirm the first command or execute the command immediately. Command sequencing must be followed exactly. Any invalid combination of commands will reset the device to Read Array. The increased number of cycles has been chosen to assure maximum data security. Commands are initialised by two preceding coded cycles which unlock the Command Interface. In addition, for Erase, command confirmation is again preceded by the two coded cycles.

P/E.C. status is indicated during command execution by Data Polling on DQ7, detection of Toggle on DQ6, or Error on DQ5 and Erase Timer DQ3 bits. Any read attempt during Program or Erase command execution will automatically output those four bits. The P/E.C. automatically sets bits DQ3, DQ5, DQ6 and DQ7. Other bits (DQ0, DQ1, DQ2 and DQ4) are reserved for future use and should be masked.

Data Polling Bit DQ7. When Programming operations are in progress, this bit outputs the complement of the bit being programmed on DQ7. During Erase operation, it outputs a '0'. After completion of the operation, DQ7 will output the bit last programmed or a '1' after erasing. Data Polling is valid only effective during P/E.C. operation, that is after the fourth W pulse for programming or after the sixth W pulse for Erase. It must be performed at the address being programmed or at an address within the sector being erased. If the byte to be programmed belongs to a protected sector the command is ignored. If all the sectors selected for erasure are protected, DQ7 will set to '0' for about 100 µs, and then return to previous addressed memory data. See Figure 9 for the Data Polling flowchart and Figure 10 for the Data Polling waveforms.

Table 12B. Read AC Characteristics

|                       |              |  |  |                     | M29     | F040               |         |      |
|-----------------------|--------------|--|--|---------------------|---------|--------------------|---------|------|
|                       |              |  |  | -120                |         | -150               |         |      |
| Symbol                | Alt          | Parameter                                  | Test Condition                                 | V <sub>CC</sub> = 5 | V ± 10% | Vcc = 5            | V ± 10% | Unit |
|                       |              |  |  | EPROM<br>Interface  |         | EPROM<br>Interface |         |      |
|                       |              |  |  | Min                 | Max     | Min                | Max     |      |
| t <sub>AVAV</sub>     | tac          | Address Valid to Next Address Valid        | $\overline{E} = V_{IL}, \overline{G} = V_{IL}$ | 120                 |         | 150                |         | ns   |
| tavav                 | <b>t</b> acc | Address Valid to Output Valid              | $\overline{E} = V_{IL}, \overline{G} = V_{IL}$ |                     | 120     |                    | 150     | ns   |
| t <sub>ELOX</sub> (1) | <b>t</b> LZ  | Chip Enable Low to Output Transition       | G = V <sub>IL</sub>                            | 0                   |         | 0                  |         | ns   |
| t <sub>ELQV</sub> (2) | <b>t</b> ce  | Chip Enable Low to Output Valid            | G = V <sub>IL</sub>                            |                     | 120     |                    | 150     | ns   |
| tGLQX (1)             | toLZ         | Output Enable Low to Output<br>Transition  | E = V <sub>IL</sub>                            | 0                   |         | 0                  |         | ns   |
| t <sub>GLQV</sub> (2) | toe          | Output Enable Low to Output Valid          | E = V <sub>IL</sub>                            |                     | 50      |                    | 55      | ns   |
| <b>t</b> EHQX         | tон          | Output Enable High to Output<br>Transition | G = V <sub>IL</sub>                            | 0                   |         | 0                  |         | ns   |
| t <sub>EHQZ</sub> (1) | <b>t</b> HZ  | Chip Enable High to Output Hi-Z            | $\overline{G} = V_{iL}$                        |                     | 30      |                    | 35      | ns   |
| <b>t</b> GHQX         | tон          | Output Enable High to Output<br>Transition | E = V <sub>IL</sub>                            | 0                   |         | 0                  |         | ns   |
| t <sub>GHQZ</sub> (1) | <b>t</b> DF  | Output Enable High to Output Hi-Z          | Ē = V <sub>IL</sub>                            |                     | 30      |                    | 35      | ns   |
| <b>t</b> AXQX         | tон          | Address Transition to Output Transition    | $\overline{E} = V_{1L}, \overline{G} = V_{1L}$ | 0                   |         | 0                  |         | ns   |

Notes: 1. Sampled only, not 100% tested.

2. G may be delayed by up to telov - tolov after the falling edge of E without increasing telov.

Toggle Bit DQ6. When Programming operations are in progress, successive attempts to read DQ6 will output complementary data. DQ6 will toggle following toggling of either G or E when G is low. The operation is completed when two successive reads yield the same output data. The next read will output the bit last programmed or a '1' after erasing. The toggle bit is valid only effective during P/E.C. operations, that is after the fourth  $\overline{W}$  pulse for programming or after the sixth W pulse for Erase. If the byte to be programmed belongs to a protected sector the command will be ignored. If the sectors selected for erasure are protected, DQ6 will toggle for about 100µs and then return back to Read. See Figure 11 for Toggle Bit flowchart and Figure 12 for Toggle Bit waveforms.

Error bit DQ5. This bit is set to '1' by the P/E.C when there is a failure of byte programming, sector erase, or bulk erase that results in invalid data being programmed in the memory sector. In case of error in sector erase or byte program, the sector in which the error occured or to which the programmed byte belongs, must be discarded. Other sectors may still be used. Error bit resets after Read/Reset (RD) instruction. In case of success, the error bit will set to '0' during Program or Erase and to valid data after write operation is completed.

Erase Timer bit DQ3. This bit is set to '0' by the P/E.C. when the last sector Erase command has been entered to the Command Interface and it is awaiting the Erase start. When the wait period is finished, after 80 to 120µs, DQ3 returns back to '1'.

Figure 6. Read Mode AC Waveforms

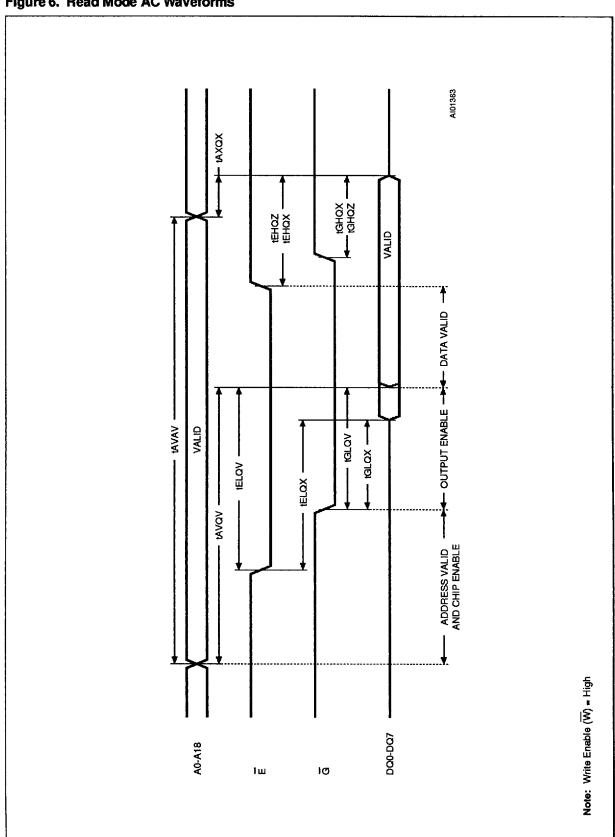


Table 13A. Write AC Characteristics, Write Enable Controlled

|                        |                 |  |                     | M29              | F040                |     |      |
|------------------------|-----------------|--|---------------------|------------------|---------------------|-----|------|
| Cumbal                 | Alt             | Beneziatan                                       | -70                 | O <sup>(2)</sup> | -90                 |     | Unit |
| Symbol                 | AR              | Parameter  | V <sub>CC</sub> = ! | 5V ± 5%          | V <sub>CC</sub> = 5 |     |      |
|                        |                 |  | SRAMI               | nterface         | EPROM Interface     |     |      |
|                        |                 |  | Min                 | Max              | Min                 | Max |      |
| t <sub>avav</sub>      | twc             | Address Valid to Next Address Valid              | 70                  |                  | 90                  |     | ns   |
| telwl                  | tcs             | Chip Enable Low to Write Enable Low              | 0                   |                  | 0                   |     | ns   |
| t <sub>WLWH</sub>      | t <sub>WP</sub> | Write Enable Low to Write Enable High            | 35                  |                  | 45                  |     | ns   |
| <b>t</b> DVWH          | tos             | Input Valid to Write Enable High                 | 30                  |                  | 45                  |     | ns   |
| twhdx                  | tон             | Write Enable High to Input Transition            | 0                   |                  | 0                   |     | ns   |
| twheh                  | <b>t</b> cH     | Write Enable High to Chip Enable High            | 0                   |                  | 0                   |     | ns   |
| <b>t</b> whwL          | twph            | Write Enable High to Write Enable Low            | 20                  |                  | 20                  |     | ns   |
| tavwl                  | tas             | Address Valid to Write Enable Low                | 0                   |                  | 0                   |     | ns   |
| twlax                  | <b>t</b> AH     | Write Enable Low to Address Transition           | 45                  |                  | 45                  |     | ns   |
| t <sub>GHWL</sub>      |                 | Output Enable High to Write Enable Low           | 0                   |                  | 0                   |     | ns   |
| tvcheL                 | tvcs            | Vcc High to Chip Enable Low                      | 50                  |                  | 50                  |     | μs   |
| t <sub>WHQV1</sub> (1) |                 | Write Enable High to Output Valid (Program)      | 10                  |                  | 10                  |     | μs   |
| t <sub>WHQV2</sub> (1) |                 | Write Enable High to Output Valid (Sector Erase) | 1.5                 | 30               | 1.5                 | 30  | sec  |
| twhaL                  | toen            | Write Enable High to Output Enable Low           | 0                   |                  | 0                   |     | ns   |

Notes: 1. Time is measured to Data Polling or Toggle Bit, twhov = twhorv + torvov

2. At grade 1 (0 to 70°C) temperature range.

Coded Cycles. The two coded cycles unlock the Command Interface. They are followed by a command input or a comand confirmation. The coded cycles consist of writing the data 0AAh at address 5555h during the first cycle and data 55h at address 2AAAh during the second cycle. Addresses are latched on the falling edge of W or E white data is latched on the rising edge of W or E. The coded cycles happen on first and second cycles of the command write or on the fourth and fifth cycles.

Read (RD) instruction. The Read instruction consists of one write operation giving the command 0F0h. It can be optionally preceded by the two coded cycles. Subsequent read operations will read the memory array addressed and output the read byte.

Read Electronic Signature (RSIG) Instruction. This instruction uses the two coded cycles followed by one write cycle giving the command 90h to address 5555h for command setup. A subsequent

address 5555h for command setup. A subsequent read will output the manufacturer code, the device code or the sector protection status depending on the levels of A0, A1, A6, A16, A17 and A18. The manufacturer code, 20h, is output when the addresses lines A0, A1 and A6 are Low, the device code, 0E2h is output when A0 is High with A1 and A6 Low.

**Read Sector Protection.** The use of Read Electronic Signature (RSIG) command also allows access to the sector protection status verify. After giving the RSIG command, A0 and A6 are set to  $V_{\rm IL}$  with A1 at  $V_{\rm IH}$ , while A16, A17 and A18 define the sector of the sector to be verified. A read in these conditions will output a 01h if sector is protected and a 00h if sector is not protected.

Table 13B. Write AC Characteristics, Write Enable Controlled

|                        |                 |  |                     | M29       | F040                            |      |     |
|------------------------|-----------------|--|---------------------|-----------|---------------------------------|------|-----|
| Combal                 | Alt             | Barranata  | -1                  | 20        | -1                              | Unit |     |
| Symbol                 | Ait             | Parameter  | V <sub>CC</sub> = 5 | V ± 10%   | Vcc = 5V ± 10%  EPROM Interface |      |     |
|                        |                 |  | EPROM               | Interface |                                 |      |     |
|                        |                 |  | Min                 | Max       | Min                             | Max  |     |
| tavav                  | twc             | Address Valid to Next Address Valid              | 120                 |           | 150                             |      | ns  |
| <b>t</b> ELWL          | tcs             | Chip Enable Low to Write Enable Low              | 0                   |           | 0                               |      | ns  |
| twLwH                  | t <sub>WP</sub> | Write Enable Low to Write Enable High            | 50                  |           | 50                              |      | ns  |
| <b>t</b> DVWH          | <b>t</b> os     | Input Valid to Write Enable High                 | 50                  |           | 50                              |      | ns  |
| twhox                  | <b>t</b> DH     | Write Enable High to Input Transition            | 0                   |           | 0                               |      | ns  |
| twhen                  | <b>t</b> cH     | Write Enable High to Chip Enable High            | 0                   |           | 0                               |      | ns  |
| twhwL                  | twpH            | Write Enable High to Write Enable Low            | 20                  |           | 20                              |      | ns  |
| tavwl.                 | tas             | Address Valid to Write Enable Low                | 0                   |           | 0                               |      | ns  |
| twlax                  | <b>t</b> AH     | Write Enable Low to Address Transition           | 50                  |           | 50                              |      | ns  |
| t <sub>GHWL</sub>      |                 | Output Enable High to Write Enable Low           | 0                   |           | 0                               |      | ns  |
| <b>t</b> VCHEL         | tvcs            | Vcc High to Chip Enable Low                      | 50                  |           | 50                              |      | μs  |
| t <sub>WHQV1</sub> (1) |                 | Write Enable High to Output Valid (Program)      | 10                  |           | 10                              |      | μs  |
| t <sub>WHQV2</sub> (1) |                 | Write Enable High to Output Valid (Sector Erase) | 1.5                 | 30        | 1.5                             | 30   | sec |
| twHGL                  | toen            | Write Enable High to Output Enable Low           | 0                   |           | 0                               |      | ns  |

Note: 1. Time is measured to Data Polling or Toggle Bit, twhov = twhorv + torvov

Bulk Erase (BE) instruction. This instruction uses six write cycles. The Erase Set-up command 80h is written to address 5555h on third cycle after the two coded cycles. The Bulk Erase Confirm command 10h is written at address 5555h on sixth cycle after another two coded cycles. If the second command given is not an erase confirm or if the coded cycles are wrong, the instruction aborts and the device is reset to Read Array. It is not necessary to program the array with 00h first as the P/E.C. will automatically do this before erasing to 0FFh. Read operations after the sixth rising edge of W or E output the status register bits. During the execution of the erase by the P/E.C., Data Polling bit DQ7 returns '0', then '1' on completion. The Toggle Bit DQ6 toggles during erase operation and stops when erase is completed. After completion the Status Register bit DQ5 returns '1' if there has been an Erase Failure because the erasure has not been verified even after the maximum number of erase cycles have been executed.

Sector Erase (SE) Instruction. This instruction uses a minimum of six write cycles. The Erase Set-up command 80h is written to address 5555h on third cycle after the two coded cycles. The Sector Erase Confirm command 30h is written on sixth cycle after another two coded cycles. During the input of the second command an address within the sector to be erased is given and latched into the memory. Additional Sector Erase confirm commands and sector addresses can be written subsequently to erase other sectors in parallel, without further coded cycles. The erase will start after an Erase timeout period of about 100µs. Thus, additional Sector Erase commands must be given within this delay. The input of a new Sector Erase command will restart the timeout period. The status of the internal timer can be monitored

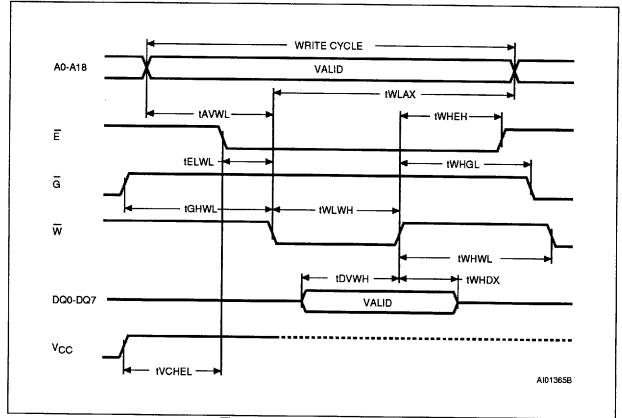


Figure 7. Write AC Waveforms, W Controlled

Note: Address are latched on the falling edge of W, Data is latched on the rising edge of W.

through the level of DQ3, if DQ3 is '0' the Sector Erase Command has been given and the timeout is running, if DQ3 is '1', the timeout has expired and the P/E.C is erasing the sector(s). If the second command given is not an erase confirm or if the coded cycles are wrong, the instruction aborts, and the device is reset to Read Array. It is not necessary to program the sector with 00h as the P/E.C. will do this automatically before to erasing to 0FFh. Read operations after the sixth rising edge of  $\overline{W}$  or  $\overline{E}$  output the status register status bits.

During the execution of the erase by the P/E.C., the memory accepts only the ES (Erase Suspend) and RD (Read/Reset) instructions. Data Polling bit DQ7 returns '0' while the erasure is in progress and '1' when it has completed. The Toggle Bit DQ6 toggles during the erase operation. It stops when erase is

completed. After completion the Status Register bit DQ5 returns '1' if there has been an Erase Failure because erasure has not completed even after the maximum number of erase cycles have been executed. In this case, it will be necessary to input a Read/Reset (RD) to the command interface in order to reset the P/E.C.

**Program (PG) instruction.** This instruction uses four write cycles. The Program command A0h is written on the third cycle after two coded cycles. A fourth write operation latches the Address on the falling edge of  $\overline{W}$  or  $\overline{E}$  and the Data to be written on its rising edge and starts the P/E.C. Read operations output the status bits after the programming has started. Memory programming is made only by writing '0' in place of '1' in a Byte.

Table 14A. Write AC Characteristics, Chip Enable Controlled

|                        |              |   |                            | M29              | F040            |     | •    |
|------------------------|--------------|---|----------------------------|------------------|-----------------|-----|------|
| Symbol                 | Alt          | Parameter                                       | -70                        | ) <sup>(2)</sup> | -90             |     | Unit |
| Cymbol                 | ~"           | Parameter                                       | <b>V</b> <sub>CC</sub> = ! | 5V ± 5%          | Vcc = 5         |     |      |
|                        |              |   | SRAMI                      | nterface         | EPROM Interface |     |      |
|                        |              |   | Min                        | Max              | Min             | Max |      |
| t <sub>AVAV</sub>      | twc          | Address Valid to Next Address Valid             | 70                         |                  | 90              |     | ns   |
| twlel                  | tws          | Write Enable Low to Chip Enable Low             | 0                          |                  | 0               |     | ns   |
| t <sub>ELEH</sub>      | <b>t</b> CP  | Chip Enable Low to Chip Enable High             | 35                         |                  | 45              |     | ns   |
| <b>t</b> oveh          | <b>t</b> os  | Input Valid to Chip Enable High                 | 30                         |                  | 45              |     | ns   |
| <b>t</b> endx          | <b>t</b> DH  | Chip Enable High to Input Transition            | 0                          |                  | 0               |     | ns   |
| <b>t</b> EHWH          | twn          | Chip Enable High to Write Enable High           | 0                          |                  | 0               |     | ns   |
| <b>t</b> ehel          | <b>t</b> cph | Chip Enable High to Chip Enable Low             | 20                         |                  | 20              |     | ns   |
| <b>t</b> avel          | <b>t</b> as  | Address Valid to Chip Enable Low                | 0                          |                  | 0               |     | ns   |
| <b>t</b> ELAX          | <b>t</b> ah  | Chip Enable Low to Address Transition           | 45                         |                  | 45              |     | ns   |
| t <sub>GHEL</sub>      |              | Output Enable High Chip Enable Low              | 0                          |                  | 0               |     | ns   |
| tvchwL                 | tvcs         | Vcc High to Write Enable Low                    | 50                         |                  | 50              |     | ns   |
| t <sub>EHQV1</sub> (1) |              | Chip Enable High to Output Valid (Program)      | 10                         |                  | 10              |     | μs   |
| t <sub>EHQV2</sub> (1) |              | Chip Enable High to Output Valid (Sector Erase) | 1.5                        | 30               | 1.5             | 30  | sec  |
| <b>t</b> EHGL          | <b>t</b> oeh | Chip Enable High to Output Enable Low           | 0                          |                  | 0               |     | ns   |

Notes: 1. Time is measured to Data Polling or Toggle Bit, twhov = twhorv + torvov 2. At grade 1 (0 to 70°C) temperature range.

Erase Suspend (ES) instruction. The Sector Erase operation may be suspended by this instruction which consists of writing the command 0B0h without any specific address code. No coded cycles are required. It allows reading of data from another sector while erase is in progress. Erase suspend is accepted only during the Sector Erase instruction execution. Writing this command during Erase timeout will, in addition to suspending the erase, terminate the timeout. The Toggle Bit DQ6 stops toggling when the P/E.C. is suspended. Toggle Bit status must be monitored at an address out of the sector being erased. Toggle Bit will stop toggling between 0.1µs and 15µs after the Erase Suspend

(ES) command has been written. The M29F040 will then automatically set to Read Memory Array mode. When erase is suspended, Read from sectors being erased will output invalid data, Read from sector not being erased is valid. During the suspension the memory will respond only to Erase Resume (ER) instruction. RD command will definitively abort erasure and result in the invalid data in the sectors being erased.

Erase Resume (ER) Instruction. If an Erase Suspend instruction was previously executed, the erase operation may be resumed by giving the command 30h, at any address, and without any coded cycles.

Table 14B. Write AC Characteristics, Chip Enable Controlled

|                        |              |   |                     | M29       | F040                |         | Unit |
|------------------------|--------------|---|---------------------|-----------|---------------------|---------|------|
| Symbol                 | Alt          | Parameter                                       | -1                  | 20        | -1                  | 50      |      |
| Symbol                 | All          | Parameter                                       | V <sub>CC</sub> = 5 | V ± 10%   | V <sub>CC</sub> = 5 | V ± 10% | Unit |
|                        |              |   | EPROM               | Interface | EPROM               |         |      |
|                        |              |   | Min                 | Max       | Min                 | Max     |      |
| tavav                  | twc          | Address Valid to Next Address Valid             | 120                 |           | 150                 |         | ns   |
| twlel                  | tws          | Write Enable Low to Chip Enable Low             | 0                   |           | 0                   |         | ns   |
| <b>t</b> ELEH          | <b>t</b> CP  | Chip Enable Low to Chip Enable High             | 50                  |           | 50                  |         | ns   |
| tovен                  | <b>t</b> os  | Input Valid to Chip Enable High                 | 50                  |           | 50                  |         | ns   |
| <b>t</b> EHDX          | <b>t</b> DH  | Chip Enable High to Input Transition            | 0                   |           | 0                   |         | ns   |
| <b>t</b> ehwh          | twn          | Chip Enable High to Write Enable High           | 0                   |           | 0                   |         | ns   |
| t <sub>EHEL</sub>      | <b>t</b> CPH | Chip Enable High to Chip Enable Low             | 20                  |           | 20                  |         | ns   |
| tavel                  | <b>t</b> as  | Address Valid to Chip Enable Low                | 0                   |           | 0                   |         | ns   |
| <b>t</b> ELAX          | <b>t</b> ah  | Chip Enable Low to Address Transition           | 50                  |           | 50                  |         | ns   |
| t <sub>GHEL</sub>      |              | Output Enable High Chip Enable Low              | 0                   | -         | 0                   |         | ns   |
| <b>t</b> vchwl         | tvcs         | Vcc High to Write Enable Low                    | 50                  |           | 50                  |         | ns   |
| t <sub>EHQV1</sub> (1) |              | Chip Enable High to Output Valid (Program)      | 10                  |           | 10                  |         | μs   |
| t <sub>EHQV2</sub> (1) |              | Chip Enable High to Output Valid (Sector Erase) | 1.5                 | 30        | 1.5                 | 30      | sec  |
| <b>t</b> EHGL          | <b>t</b> oeh | Chip Enable High to Output Enable Low           | 0                   |           | 0                   |         | ns   |

Note: 1. Time is measured to Data Polling or Toggle Bit, twhov = twhorv + torvov

Programing. The memory can be programmed byte-by-byte. The program sequence is started by the two coded cycles, followed by writing the Program command (0A0h) to the Command Interface. This is followed by writing the address and data byte to the memory. The Program/Erase Controller automatically starts and performs the programming after the fourth write operation. During programming the memory status is checked by reading the status bits DQ5, DQ6 and DQ7 which show the status of the P/E.C. DQ6 and DQ7 determine if programming is on going or has completed and DQ5 allows a check to be made for any possible error.

# **Power Up**

The memory Command Interface is reset on power up to Read Array. Either  $\overline{E}$  or  $\overline{W}$  must be tied to  $V_{IH}$  during Power-up to allow maximum security and the possibility to write a command on the first rising adge of  $\overline{E}$  or  $\overline{W}$ . Any write cycle initiation is blocked when  $V_{CC}$  is below  $V_{LKO}$ .

## Supply Rails

Normal precautions must be taken for supply voltage decoupling, each device in a system should have the Vcc rail decoupled with a 0.1µF capacitor close to the Vcc and Vss pins. The PCB trace widths should be sufficient to carry the Vcc program and erase currents required.

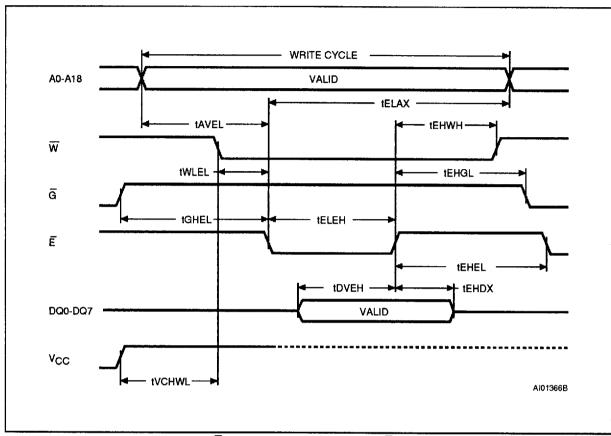


Figure 8. Write AC Waveforms, E Controlled

**Note:** Address are latched on the falling edge of  $\overline{E}$ , Data is latched on the rising edge of  $\overline{E}$ .

Table 15A. Data Polling and Toggle Bit AC Characteristics  $^{(1)}$  (T<sub>A</sub> = 0 to 70°C, -20 to 85°C, -40 to 85°C or -40 to 125°C)

|                         |     |   |                     | M29              | F040            |         |      |
|-------------------------|-----|---|---------------------|------------------|-----------------|---------|------|
| Symbol                  | Alt | Parameter   | -70                 | ) <sup>(3)</sup> | -90             |         | Unit |
| Symbol                  |     | Parameter   | V <sub>CC</sub> = { | 5V ± 5%          | Vcc = 5         | V ± 10% |      |
|                         |     |   | SRAMI               | nterface         | EPROM Interface |         |      |
|                         |     |   | Min                 | Max              | Min             | Max     |      |
| twHQ7V1 (2)             |     | Write Enab <u>le</u> High to DQ7 Valid<br>(Program, W Controlled) | 10                  |                  | 10              |         | μs   |
| twHQ7V2 (2)             |     | Write Enable High to DQ7 Valid (Sector Erase, W Controlled)       | 1.5                 | 30               | 1.5             | 30      | sec  |
| t <sub>EHQ7V1</sub> (2) |     | Chip Enable High to DQ7 Valid (Program, E Controlled)             | 10                  |                  | 10              |         | μs   |
| t <sub>EHQ7V2</sub> (2) |     | Chip Enable High to DQ7 Valid<br>(Sector Erase, E Controlled)     | 1.5                 | 30               | 1.5             | 30      | sec  |
| tazvav                  |     | Q7 Valid to Output Valid (Data Polling)                           |                     | 30               |                 | 35      | ns   |
| <b>t</b> whavi          |     | Write Enable High to Output Valid (Program)                       | 10                  |                  | 10              |         | μs   |
| twHQV2                  |     | Write Enable High to Output Valid (Sector Erase)                  | 1.5                 | 30               | 1.5             | 30      | sec  |
| <b>t</b> EHQV1          |     | Chip Enable High to Output Valid (Program)                        | 10                  |                  | 10              |         | μs   |
| <b>t</b> EHQV2          |     | Chip Enable High to Output Valid (Sector Erase)                   | 1.5                 | 30               | 1.5             | 30      | sec  |

Notes: 1. All other timings are defined in Read AC Characteristics table.
2. twhorv is the Program or Erase time.
3. At grade 1 (0 to 70°C) temperature range.

Table 15B. Data Polling and Toggle Bit AC Characteristics  $^{(1)}$  (T<sub>A</sub> = 0 to 70°C, -20 to 85°C, -40 to 85°C or -40 to 125°C)

|                                |     |  |                 | M29       | F040                |         |      |  |
|--------------------------------|-----|--|-----------------|-----------|---------------------|---------|------|--|
| Symbol                         | Alt | Parameter  | -1              | 20        | 150                 |         | Unit |  |
| Symbol                         | AIL | Paramoter  | <b>V</b> cc = 5 | V ± 10%   | V <sub>CC</sub> = 5 | V ± 10% |      |  |
| 6                              |     |  | EPROM           | Interface | EPROM Interface     |         |      |  |
|                                |     |  | Min             | Max       | Min                 | Max     |      |  |
| <b>t</b> wнa7v1 <sup>(2)</sup> |     | Write Enable High to DQ7 Valid (Program, W Controlled)         | 10              |           | 10                  |         | ms   |  |
| twHQ7V2 (2)                    |     | Write Enable High to DQ7 Valid<br>(Sector Erase, W Controlled) | 1.5             | 30        | 1.5                 | 30      | sec  |  |
| t <sub>EHQ7V1</sub> (2)        |     | Chip Enable High to DQ7 Valid (Program, E Controlled)          | 10              |           | 10                  |         | ms   |  |
| <b>t</b> ehq7V2 <sup>(2)</sup> |     | Chip Enable High to DQ7 Valid<br>(Sector Erase, E Controlled)  | 1.5             | 30        | 1.5                 | 30      | sec  |  |
| tazvav                         |     | Q7 Valid to Output Valid (Data Polling)                        |                 | 50        |                     | 55      | ns   |  |
| <b>t</b> whavi                 |     | Write Enable High to Output Valid (Program)                    | 10              |           | 10                  |         | μs   |  |
| twhav2                         |     | Write Enable High to Output Valid (Sector Erase)               | 1.5             | 30        | 1.5                 | 30      | sec  |  |
| <b>t</b> EHQV1                 |     | Chip Enable High to Output Valid (Program)                     | 10              |           | 10                  |         | μs   |  |
| <b>t</b> EHQV2                 |     | Chip Enable High to Output Valid (Sector Erase)                | 1.5             | 30        | 1.5                 | 30      | sec  |  |

Notes: 1. All other timings are defined in Read AC Characteristics table.

2. twhozv is the Program or Erase time.

Figure 9. Data Polling DQ7 AC Waveforms

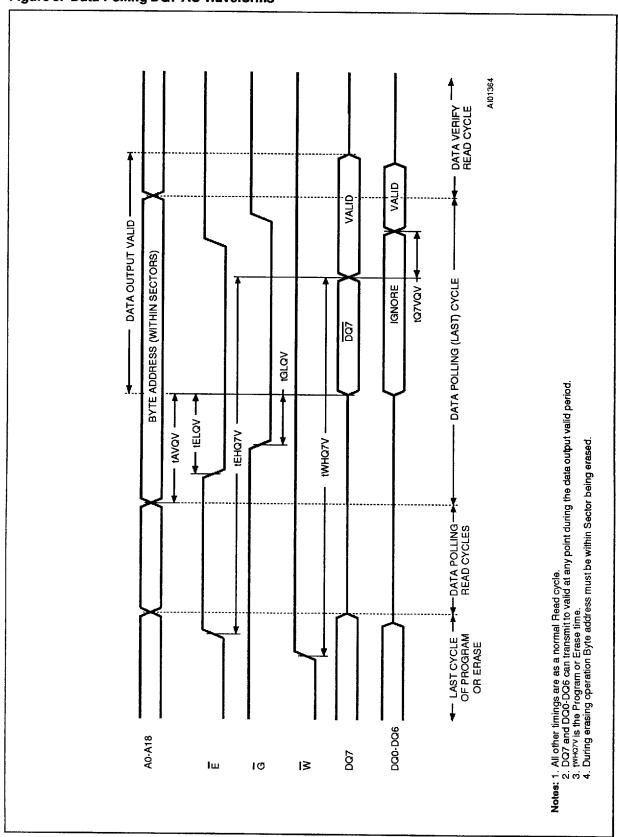


Figure 10. Data Polling Flow-chart

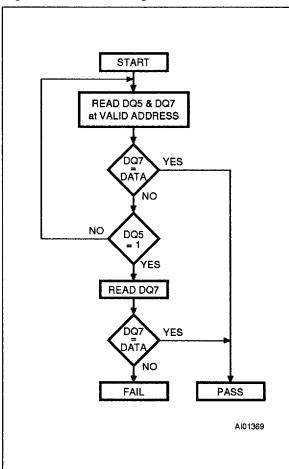


Figure 11. Data Toggle Flow-chart

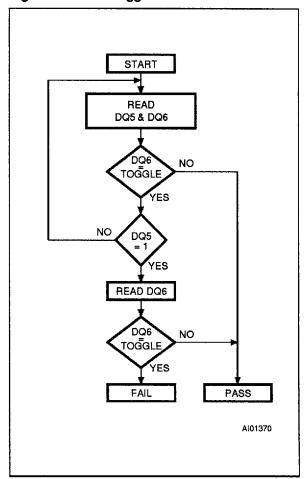


Table 16. Program, Erase Times and Program, Erase Endurance Cycles ( $T_A = 0$  to  $70^{\circ}$ C;  $V_{CC} = 5V \pm 10\%$  or  $5V \pm 5\%$ )

| Parameter                         |         | M29F040 |      | Unit   |
|-----------------------------------|---------|---------|------|--------|
| . aramotor                        | Min     | Тур     | Max  | Oint   |
| Chip Program (Byte)               |         | 6       |      | sec    |
| Bulk Erase (Preprogrammed)        |         | 2.5     | 30   | sec    |
| Bulk Erase                        |         | 8.5     |      | sec    |
| Sector Erase (Preprogrammed)      |         | 1       | 30   | sec    |
| Sector Erase                      |         | 1.5     |      | sec    |
| Byte Program                      | 10      |         | 1200 | μs     |
| Program/Erase Cycles (per Sector) | 100,000 |         |      | cycles |

Figure 12. Data Toggle DQ6 AC Waveforms

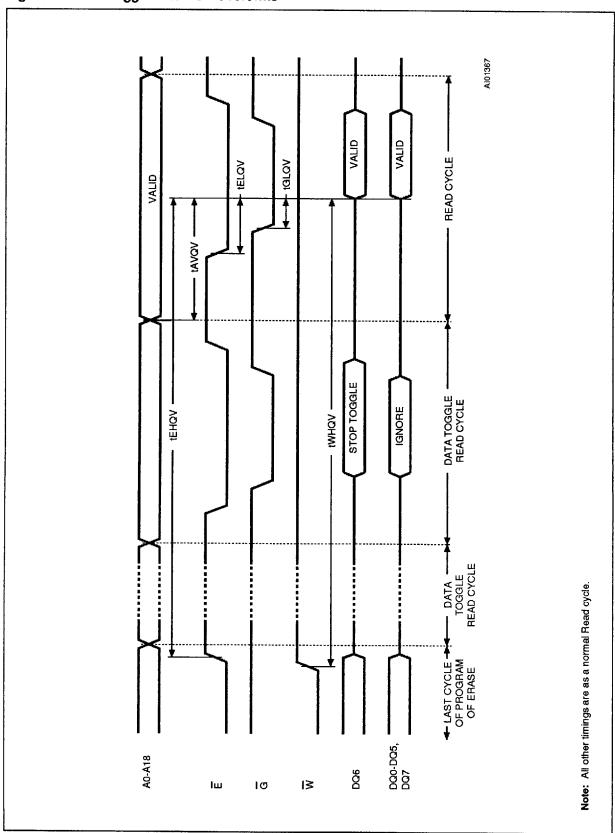
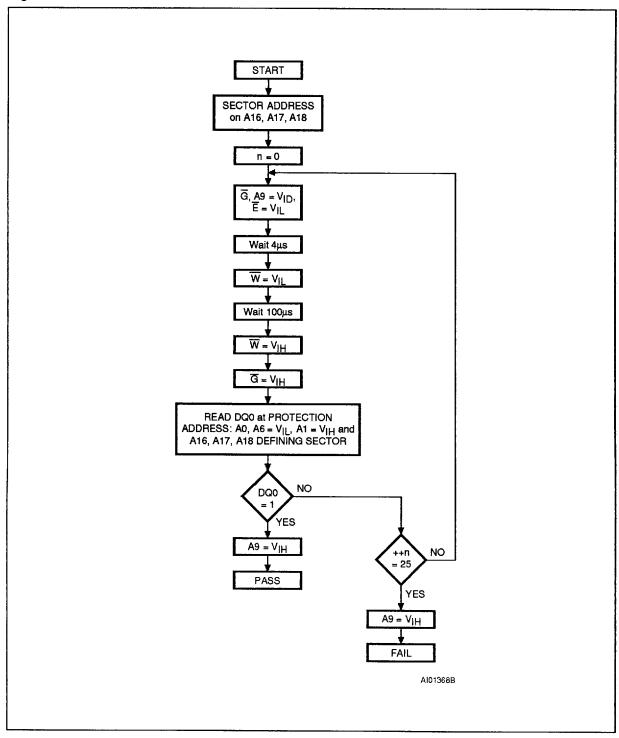


Figure 13. Sector Protection Flow-chart



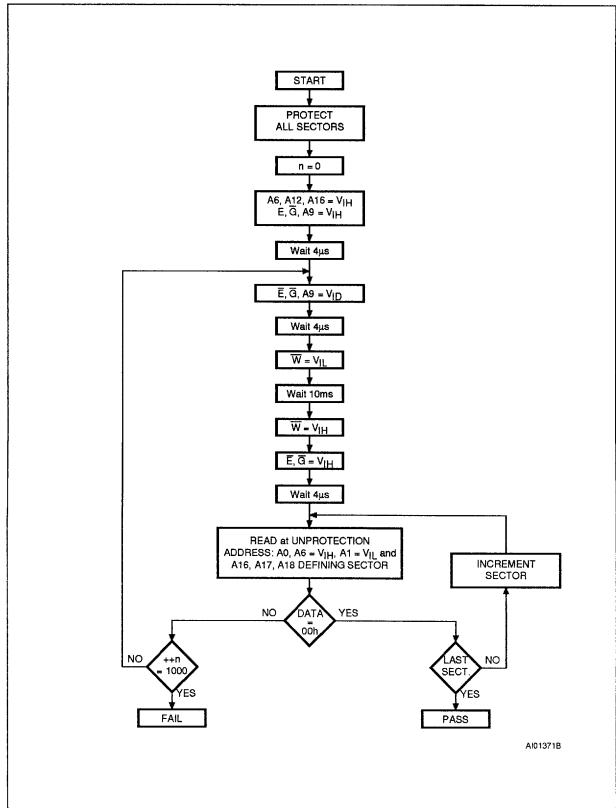
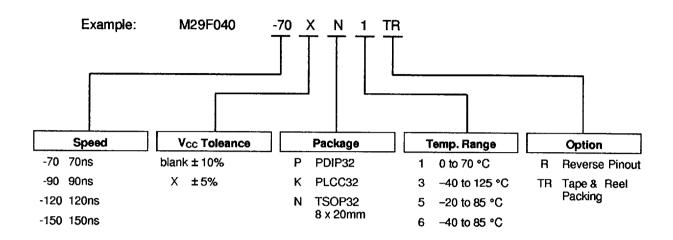


Figure 14. Sector Unprotecting Flow-chart

# **ORDERING INFORMATION SCHEME**

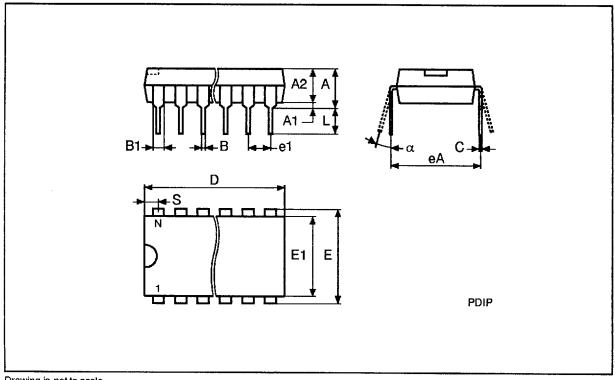


For a list of available options ( $V_{CC}$  Range, Speed, etc...) refer to the current Memory Shortform catalogue. For further information on any aspect of this device, please contact SGS-THOMSON Sales Office nearest to you.

PDIP32 - 32 pin Plastic DIP, 600 mils width

| Symb |       | mm    |       |       | inches |       |
|------|-------|-------|-------|-------|--------|-------|
|      | Тур   | Min   | Max   | Тур   | Min    | Max   |
| Α    |       |       | 4.83  |       |        | 0.190 |
| A1   |       | 0.38  | _     |       | 0.015  | -     |
| A2   | -     | -     | -     | _     | _      | -     |
| В    |       | 0.41  | 0.51  |       | 0.016  | 0.020 |
| B1   |       | 1.14  | 1.40  |       | 0.045  | 0.055 |
| С    |       | 0.20  | 0.30  |       | 0.008  | 0.012 |
| D    |       | 41.78 | 42.04 |       | 1.645  | 1.655 |
| E    |       | 15.24 | 15.88 |       | 0.600  | 0.625 |
| E1   |       | 13.46 | 13.97 |       | 0.530  | 0.550 |
| e1   | 2.54  | _     | _     | 0.100 | -      | _     |
| eA   | 15.24 | _     | _     | 0.600 | _      | -     |
| L    |       | 3.18  | 3.43  |       | 0.125  | 0.135 |
| S    |       | 1.78  | 2.03  |       | 0.070  | 0.080 |
| α    |       | 0°    | 15°   |       | 0°     | 15°   |
| N    |       | 32    |       |       | 32     |       |

PDIP32

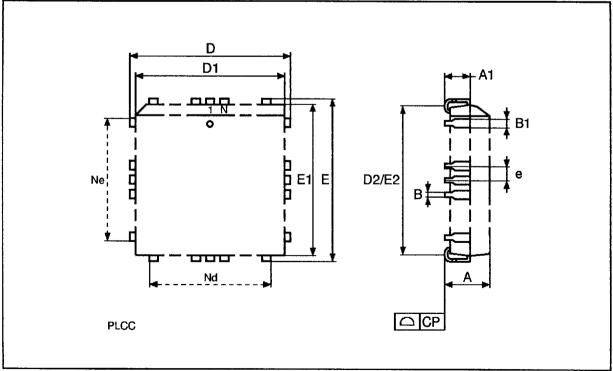


Drawing is not to scale

PLCC32 - 32 lead Plastic Leaded Chip Carrier, rectangular

| Symb |      | mm    |       |       | inches   |       |
|------|------|-------|-------|-------|----------|-------|
| Cymb | Тур  | Min   | Max   | Тур   | Min      | Max   |
| Α    |      | 2.54  | 3.56  |       | 0.100    | 0.140 |
| A1   |      | 1.52  | 2.41  |       | 0.060    | 0.095 |
| В    |      | 0.33  | 0.53  |       | 0.013    | 0.021 |
| B1   |      | 0.66  | 0.81  |       | 0.026    | 0.032 |
| D    |      | 12.32 | 12.57 |       | 0.485    | 0.495 |
| D1   |      | 11.35 | 11.56 |       | 0.447    | 0.455 |
| D2   |      | 9.91  | 10.92 |       | 0.390    | 0.430 |
| E    |      | 14.86 | 15.11 |       | 0.585    | 0.595 |
| E1   |      | 13.89 | 14.10 |       | 0.547    | 0.555 |
| E2   |      | 12.45 | 13.46 |       | 0.490    | 0.530 |
| е    | 1.27 | -     | _     | 0.050 | <u>-</u> | -     |
| N    |      | 32    |       |       | 32       |       |
| Nd   |      | 7     |       |       | 7        |       |
| Ne   |      | 9     |       |       | 9        |       |
| CP   |      |       | 0.10  |       |          | 0.004 |

PLCC32



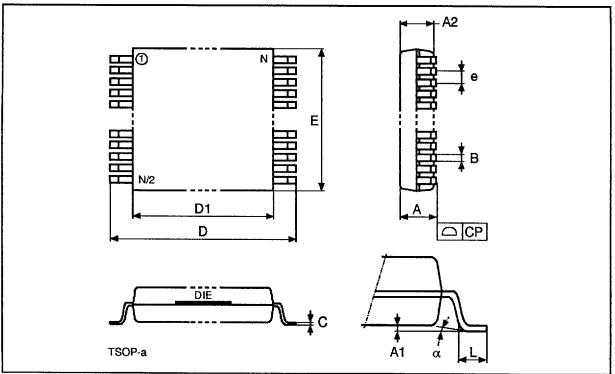
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# TSOP32 Normal Pinout - 32 lead Plastic Thin Small Outline, 8 x 20mm

| Symb       |      | mm    |       | inches |       |       |  |  |
|------------|------|-------|-------|--------|-------|-------|--|--|
| Cymb       | Тур  | Min   | Max   | Тур    | Min   | Max   |  |  |
| Α          |      |       | 1.20  |        |       | 0.047 |  |  |
| <b>A</b> 1 |      | 0.05  | 0.17  |        | 0.002 | 0.006 |  |  |
| A2         |      | 0.95  | 1.50  |        | 0.037 | 0.059 |  |  |
| В          |      | 0.15  | 0.27  |        | 0.006 | 0.011 |  |  |
| С          |      | 0.10  | 0.21  |        | 0.004 | 0.008 |  |  |
| D          |      | 19.80 | 20.20 |        | 0.780 | 0.795 |  |  |
| D1         |      | 18.30 | 18.50 |        | 0.720 | 0.728 |  |  |
| Е          |      | 7.90  | 8.10  |        | 0.311 | 0.319 |  |  |
| е          | 0.50 | _     | -     | 0.020  | _     | -     |  |  |
| L          |      | 0.50  | 0.70  |        | 0.020 | 0.028 |  |  |
| α          |      | 0 °C  | 5 °C  |        | 0 °C  | 5 °C  |  |  |
| N          |      | 32    |       |        | 32    |       |  |  |
| СР         |      |       | 0.10  |        |       | 0.004 |  |  |

TSOP32

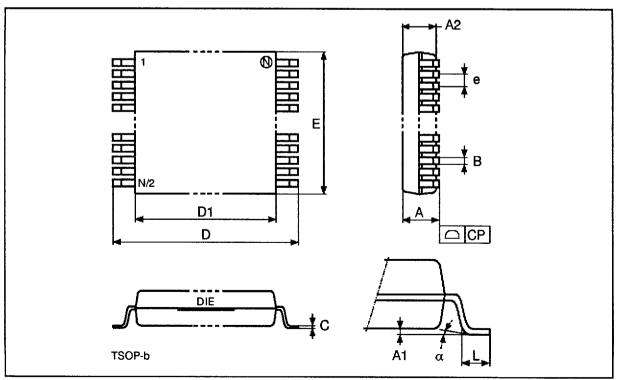


Drawing is not to scale

TSOP32 Reverse Pinout - 32 lead Plastic Thin Small Outline, 8 x 20mm

| Symb       | mm   |       |       | inches |       |       |
|------------|------|-------|-------|--------|-------|-------|
|            | Тур  | Min   | Max   | Тур    | Min   | Max   |
| Α          |      |       | 1.20  |        |       | 0.047 |
| <b>A</b> 1 |      | 0.05  | 0.17  |        | 0.002 | 0.006 |
| A2         |      | 0.95  | 1.50  |        | 0.037 | 0.059 |
| В          |      | 0.15  | 0.27  |        | 0.006 | 0.011 |
| С          |      | 0.10  | 0.21  |        | 0.004 | 0.008 |
| D          |      | 19.80 | 20.20 |        | 0.780 | 0.795 |
| D1         |      | 18.30 | 18.50 |        | 0.720 | 0.728 |
| E          |      | 7.90  | 8.10  |        | 0.311 | 0.319 |
| е          | 0.50 | _     | _     | 0.020  | _     | _     |
| L          |      | 0.50  | 0.70  |        | 0.020 | 0.028 |
| α          |      | 0 ℃   | 5 °C  |        | 0 °C  | 5 °C  |
| N          | 32   |       |       | 32     |       |       |
| CP         |      |       | 0.10  |        |       | 0.004 |

TSOP32



Drawing is not to scale

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